## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination WU, CHIN-LONG Examiner Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
\$	Α	US-6,583,442	06-2003	Ito, Shigetoshi	257/79
\$	В	US-5,747,363	05-1998	Wei et al.	438/5
女	C	US-6,621,213	09-2003	Kawashima, Toshitaka	313/506
文	ם	US-6,496,973	12-2002	Kusuda et al.	716/19
办	Е	US-6,180,960	01-2001	Kusuda et al.	257/91
A	F	US-5,869,929	02-1999	Eida et al.	313/501
7	O	US-2003/0141807	07-2003	Kawase, Takeo	313/498
1	Н	US-2002/0084536	07-2002	Sundahl et al.	257/784
	ı	US-			
	J	US-			
	Κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.